



## General Description

The DMTH10H025SK3-13 use advanced SGT MOSFET technology to provide low  $R_{DS(ON)}$ , low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness.

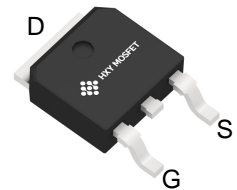
## General Features

$V_{DS} = 100V$   $I_D = 40A$

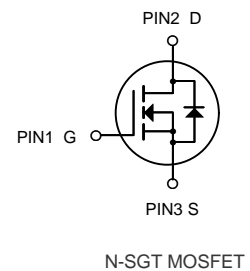
$R_{DS(ON)} < 23m\Omega$  @  $V_{GS} = 10V$

## Applications

Consumer electronic power supply  
Motor control  
Synchronous-rectification  
Isolated DC  
Synchronous-rectification applications



TO-252-2L



## Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
DMTH10H025SK3-13	TO-252-2L	HXY MOSFET	2500

## Absolute Maximum Ratings at $T_J = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain source voltage	100	V
$V_{GS}$	Gate source voltage	$\pm 20$	V
$I_D$	Continuous drain current <sup>1)</sup> , $T_C = 25^\circ C$	40	A
$I_D$ , pulse	Pulsed drain current <sup>2)</sup> , $T_C = 25^\circ C$	100	A
$P_D$	Power dissipation <sup>3)</sup> , $T_C = 25^\circ C$	27	W
EAS	Single pulsed avalanche energy <sup>5)</sup>	16	mJ
$T_{stg}$ , $T_J$	Operation and storage temperature	-55 to 150	$^\circ C$
$R_{\theta JC}$	Thermal resistance, junction-case	4.65	$^\circ C/W$
$R_{\theta JA}$	Thermal resistance, junction-ambient <sup>4)</sup>	62	$^\circ C/W$



**Electrical Characteristics** at  $T_j=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	100	-	-	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V	-	-	1	μA
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
On Characteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.2	1.8	2.6	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 15A	-	20	23	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 10A	-	-	33	mΩ
g <sub>fs</sub>	Forward Threshold Voltage	V <sub>DS</sub> = 10V, I <sub>D</sub> = 20A	-	22	-	S
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> = V <sub>GS</sub> =0V, f = 1.0MHz	-	1.62	-	Ω
Dynamic Characteristics						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 50V, V <sub>GS</sub> = 0V, f = 1.0MHz	-	822	-	pF
C <sub>oss</sub>	Output Capacitance		-	310	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	23.5	-	pF
Switching Characteristics						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 50V, I <sub>D</sub> = 20A, V <sub>GS</sub> = 10V	-	22.7	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	6.2	-	
Q <sub>gd</sub>	Gate-Drain(“Miller”) Charge		-	5.3	-	
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 50V, I <sub>D</sub> = 20A, R <sub>G</sub> = 3Ω, V <sub>GS</sub> =10V	-	15	-	ns
t <sub>r</sub>	Turn-On Rise Time		-	3.2	-	
t <sub>d(off)</sub>	Turn-Off Delay Time		-	30	-	
t <sub>f</sub>	Turn-Off Fall Time		-	7.6	-	
Diode Characteristics						
I <sub>s</sub>	Continuous Source Current		-	-	40	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>s</sub> =20A . V <sub>GS</sub> = 0V	-	0.88	1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =20A,	-	45	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>SD</sub> /dt=100A/μs	-	59	-	nC

Notes:

1. The value of  $R_{\theta JC}$  is measured in a still air environment with  $T_A = 25^\circ\text{C}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
2. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
3. Single pulse width limited by junction temperature  $T_{J(MAX)} = 150^\circ\text{C}$ .
4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
5. The maximum current rating is package limited.
6. The EAS data shows Max. rating. The test condition is  $V_{DS} = 50V, V_{GS} = 10V, L = 0.5mH$



## Electrical Characteristics Diagrams

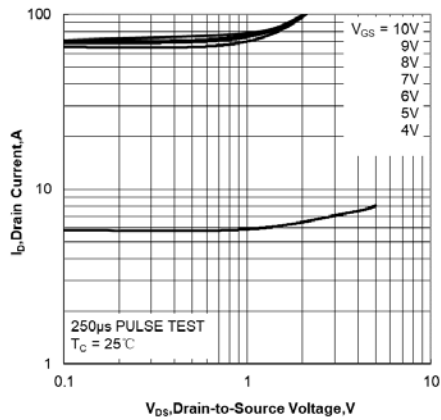


Figure 1. Output Characteristics

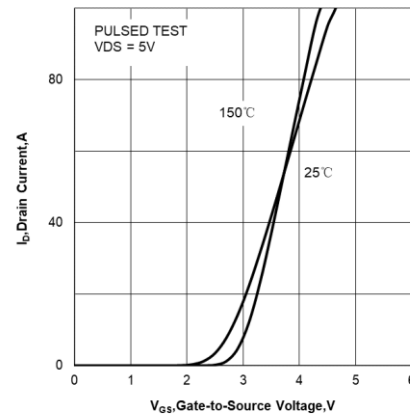


Figure 2. Transfer Characteristics

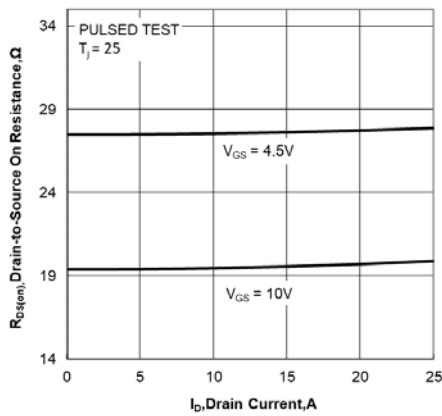


Figure 3. Drain-to-Source On Resistance  
vs Drain Current

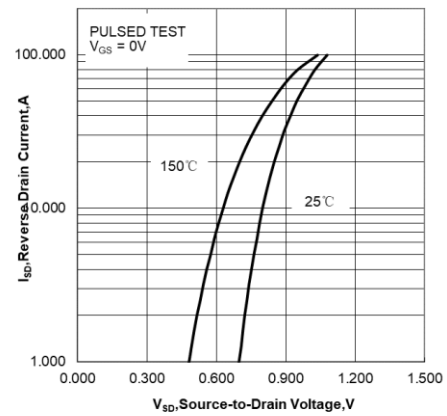


Figure 4. Body Diode Forward Voltage  
vs Source Current and Temperature

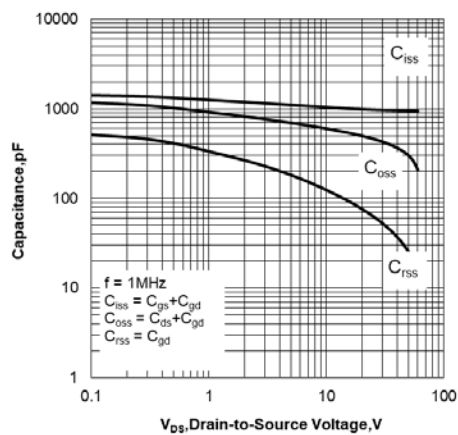


Figure 5. Capacitance Characteristics

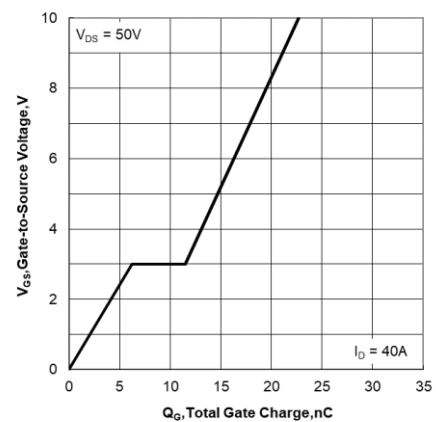


Figure 6. Gate Charge Characteristics

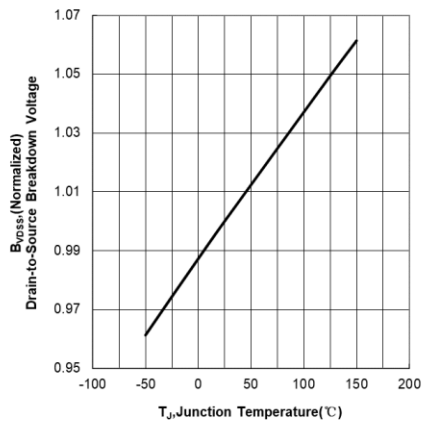


Figure 7. Normalized Breakdown Voltage  
vs Junction Temperature

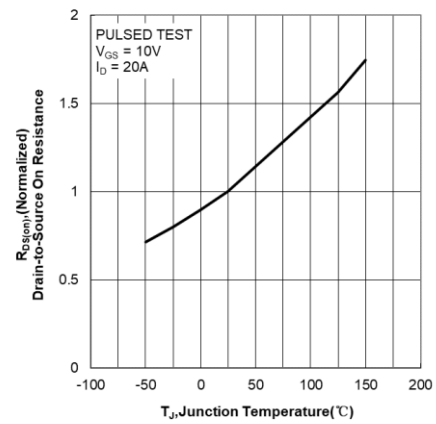


Figure 8. Normalized On Resistance vs  
Junction Temperature

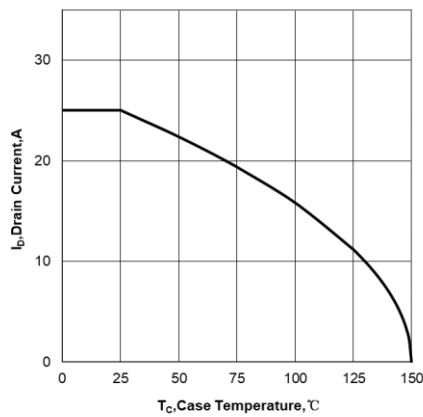


Figure 9. Maximum Continuous Drain Current  
vs Case Temperature

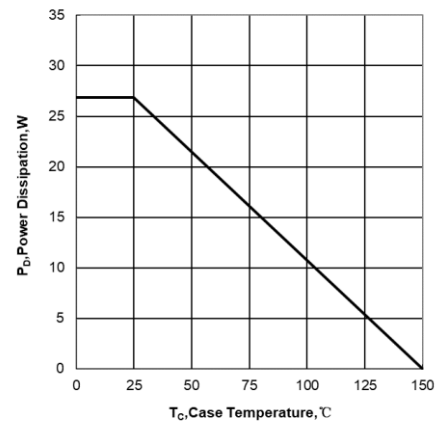


Figure 10. Maximum Power Dissipation  
vs Case Temperature

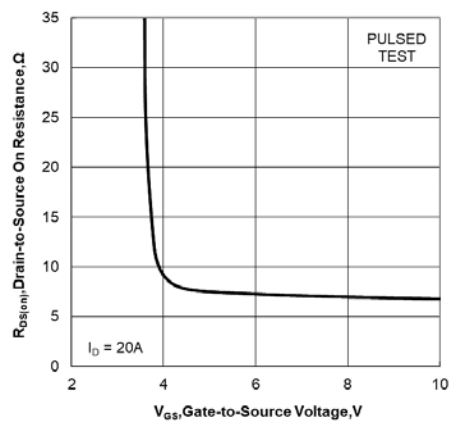


Figure 11. Drain-to-Source On Resistance vs Gate

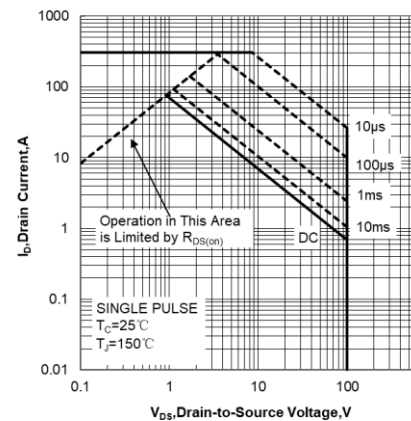


Figure 12. Maximum Safe Operating Area

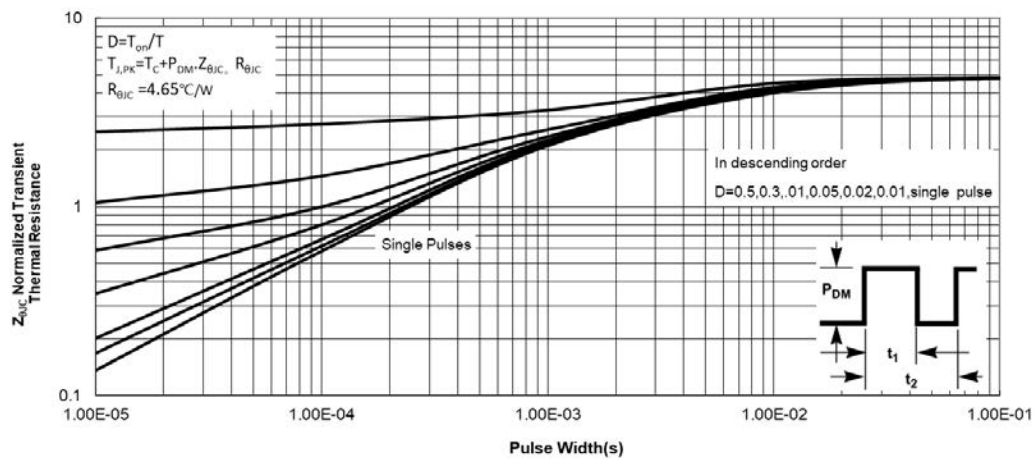
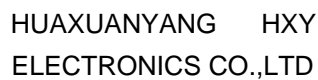
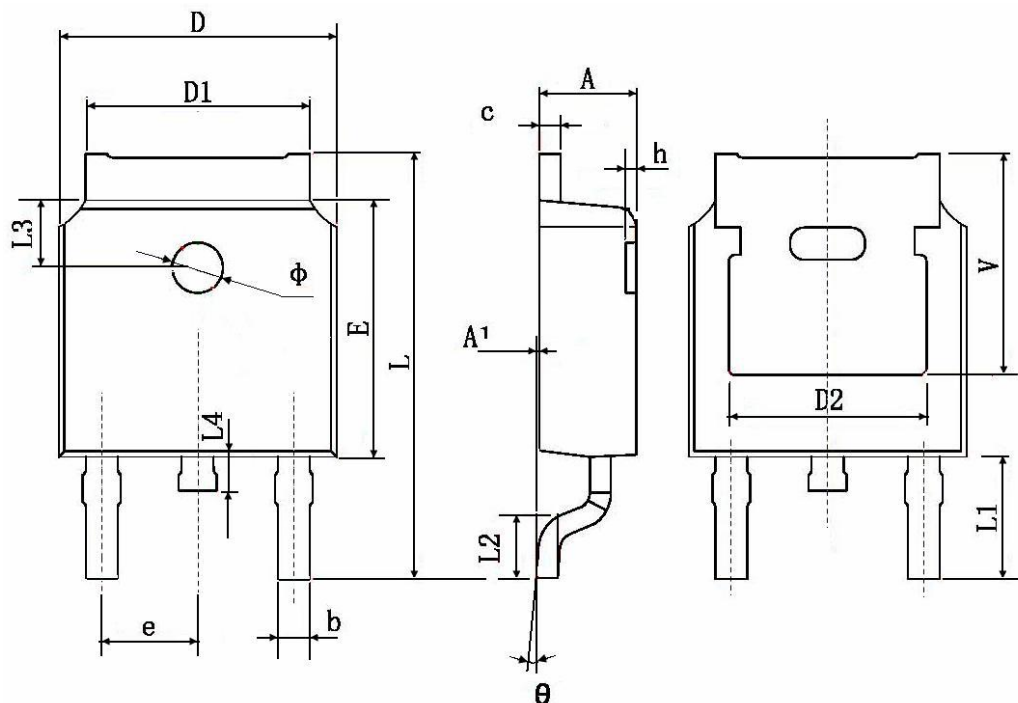


Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



**DMTH10H025SK3-13**  
N-SGT Enhancement Mode MOSFET

## TO-252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	0.483 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	



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